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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 09/615,045 | SHINICHIRO UENO | |
| | | Examiner | Art Unit | Page 1 of 1 |
| | | Vernal U Brown | 2635 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-5,940,006 | 08-1999 | MacLellan et al. | 340/10.1 |
| | B | US-5,963,144 | 10-1999 | Kruest, James R. | 340/10.1 |
| | C | US-5,537,105 | 07-1996 | Marsh et al. | 340/10.32 |
| | D | US-5,559,507 | 09-1996 | Beigel, Michael L. | 340/10.34 |
| | E | US-6,140,924 | 10-2000 | Chia et al. | 340/572.5 |
| | F | US-5,099,227 | 03-1992 | Geiszler et al. | 340/572.5 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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